

Notice of References Cited

Application/Control No.

10/591,058

Applicant(s)/Patent Under
Reexamination
FUJII ET AL.

Examiner

BRIAN R. SLAWSKI

Art Unit

1791

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,557,262 A	01-1971	Mitchell, Reid L. et al.	264/37.32
*	B	US-3,737,354 A	06-1973	Hattori, Takeo	156/229
*	C	US-4,272,312 A	06-1981	Thompson, Kenneth P.	156/244.11
*	D	US-4,521,359 A	06-1985	Tsien, Hsue C.	264/104
*	E	US-2004/0108621 A1	06-2004	Kegasawa et al.	264/171.1
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.